# **Freescale Semiconductor**

Technical Data 查询"MRF1535N"供应商

# **RF Power Field Effect Transistors**

# N-Channel Enhancement-Mode Lateral MOSFETs

Designed for broadband commercial and industrial applications with frequencies to 520 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common source amplifier applications in 12.5 volt mobile FM equipment.

Specified Performance @ 520 MHz, 12.5 Volts
 Output Power — 35 Watts
 Power Gain — 13.5 dB
 Efficiency — 55%

• Capable of Handling 20:1 VSWR, @ 15.6 Vdc, 520 MHz, 2 dB Overdrive

#### **Features**

- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Broadband Full Power Across the Band: 135-175 MHz 400-470 MHz 450-520 MHz
- 200°C Capable Plastic Package
- N Suffix Indicates Lead-Free Terminations. RoHS Compliant.
- In Tape and Reel. T1 Suffix = 500 Units per 44 mm, 13 inch Reel.

## Document Number: MRF1535N Rev. 13, 6/2009

VD0HS

# MRF1535NT1 MRF1535FNT1

520 MHz, 35 W, 12.5 V LATERAL N-CHANNEL BROADBAND RF POWER MOSFETS



CASE 1264A-03, STYLE 1 TO-272-6 PLASTIC MRF1535FNT1

**Table 1. Maximum Ratings** 

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	-0.5, +40	Vdc
Gate-Source Voltage	$V_{GS}$	±20	Vdc
Drain Current — Continuous	I <sub>D</sub>	6	Adc
Total Device Dissipation @ T <sub>C</sub> = 25°C (1) Derate above 25°C	P <sub>D</sub>	135 0.50	W W/°C
Storage Temperature Range	T <sub>stg</sub>	- 65 to +150	°C
Operating Junction Temperature	TJ	200	°C

#### **Table 2. Thermal Characteristics**

Characteristic	Symbol	Value <sup>(2)</sup>	Unit
Thermal Resistance, Junction to Case	$R_{ heta JC}$	0.90	°C/W

### **Table 3. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

1. Calculated based on the formula  $P_D = \frac{T_J - T_C}{R_{B,IC}}$ 

MTTF calculator available at <a href="http://www.freescale.com/rf">http://www.freescale.com/rf</a>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

NOTE - <u>CAUTION</u> - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.



Table 4. Electrical Characteristics ( $T_A = 25$ °C unless otherwise noted)

查询"MRF1535N"供应商racteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics	•				
Drain-Source Breakdown Voltage $(V_{GS} = 0 \text{ Vdc}, I_D = 100 \mu\text{Adc})$	V <sub>(BR)DSS</sub>	60	_	_	Vdc
Zero Gate Voltage Drain Current (V <sub>DS</sub> = 60 Vdc, V <sub>GS</sub> = 0 Vdc)	I <sub>DSS</sub>	_	_	1	μAdc
Gate-Source Leakage Current (V <sub>GS</sub> = 10 Vdc, V <sub>DS</sub> = 0 Vdc)	I <sub>GSS</sub>	_	_	0.3	μAdc
On Characteristics					
Gate Threshold Voltage ( $V_{DS}$ = 12.5 Vdc, $I_D$ = 400 $\mu$ A)	V <sub>GS(th)</sub>	1	_	2.6	Vdc
Drain-Source On-Voltage $(V_{GS} = 5 \text{ Vdc}, I_D = 0.6 \text{ A})$	R <sub>DS(on)</sub>	_	_	0.7	Ω
Drain-Source On-Voltage (V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 2.0 Adc)	V <sub>DS(on)</sub>	_	_	1	Vdc
Dynamic Characteristics	1				
Input Capacitance (Includes Input Matching Capacitance) (V <sub>DS</sub> = 12.5 Vdc, V <sub>GS</sub> = 0 V, f = 1 MHz)	C <sub>iss</sub>	_	_	250	pF
Output Capacitance (V <sub>DS</sub> = 12.5 Vdc, V <sub>GS</sub> = 0 V, f = 1 MHz)	C <sub>oss</sub>	_	_	150	pF
Reverse Transfer Capacitance (V <sub>DS</sub> = 12.5 Vdc, V <sub>GS</sub> = 0 V, f = 1 MHz)	C <sub>rss</sub>	_	_	20	pF
RF Characteristics (In Freescale Test Fixture)	+	1	+	•	
Common-Source Amplifier Power Gain (V <sub>DD</sub> = 12.5 Vdc, P <sub>out</sub> = 35 Watts, I <sub>DQ</sub> = 500 mA) f = 520 MHz	G <sub>ps</sub>	_	13.5	_	dB
Drain Efficiency $(V_{DD} = 12.5 \text{ Vdc}, P_{out} = 35 \text{ Watts}, I_{DQ} = 500 \text{ mA})$ f = 520 MHz	η	_	55	_	%

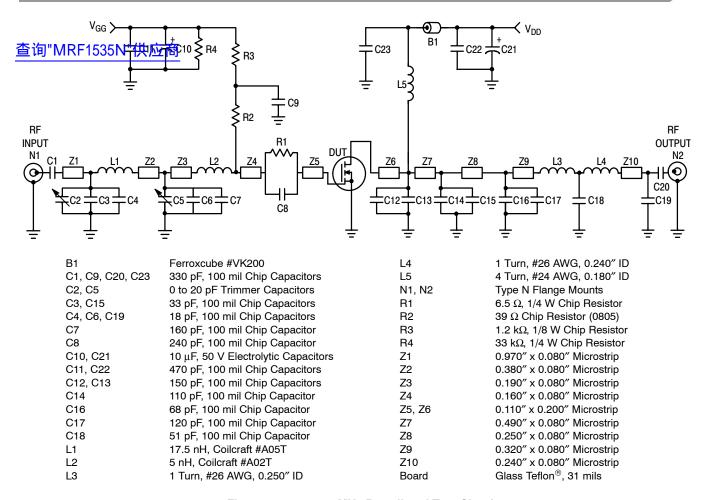


Figure 1. 135 - 175 MHz Broadband Test Circuit

#### **TYPICAL CHARACTERISTICS, 135 - 175 MHz**

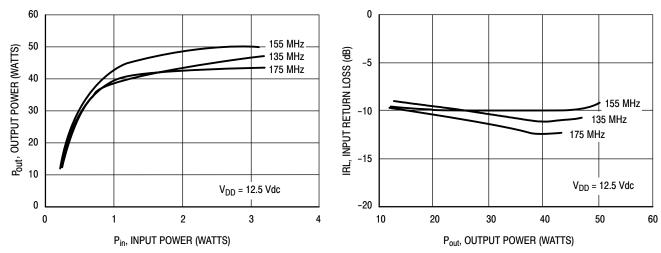


Figure 2. Output Power versus Input Power

Figure 3. Input Return Loss versus Output Power

## **TYPICAL CHARACTERISTICS, 135 - 175 MHz**



Figure 4. Gain versus Output Power

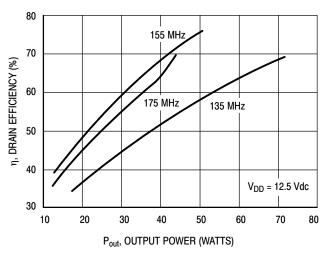


Figure 5. Drain Efficiency versus Output Power

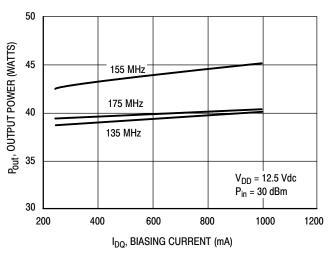


Figure 6. Output Power versus Biasing Current

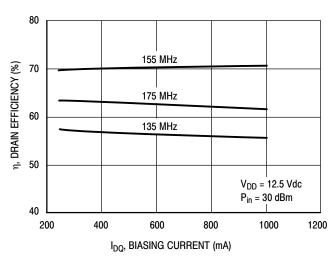


Figure 7. Drain Efficiency versus Biasing Current

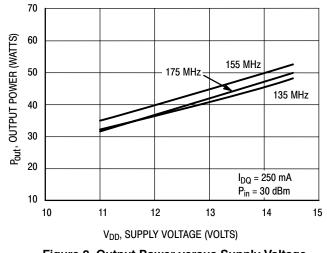


Figure 8. Output Power versus Supply Voltage

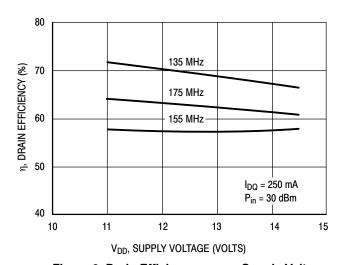
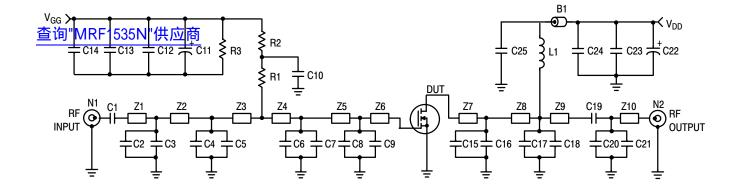


Figure 9. Drain Efficiency versus Supply Voltage



B1	Ferroxcube VK200	C21	1.8 pF, 100 mil Chip Capacitor
C1	160 pF, 100 mil Chip Capacitor	L1	47.5 nH, 5 Turn, Coilcraft
C2	3 pF, 100 mil Chip Capacitor	N1, N2	Type N Flange Mounts
C3	3.6 pF, 100 mil Chip Capacitor	R1	500 Ω Chip Resistor (0805)
C4	2.2 pF, 100 mil Chip Capacitor	R2	1 kΩ Chip Resistor (0805)
C5	10 pF, 100 mil Chip Capacitor	R3	33 kΩ, 1/8 W Chip Resistor
C6, C7	16 pF, 100 mil Chip Capacitors	Z1	0.480" x 0.080" Microstrip
C8, C15, C16	27 pF, 100 mil Chip Capacitors	Z2	1.070" x 0.080" Microstrip
C9	43 pF, 100 mil Chip Capacitor	Z3	0.290" x 0.080" Microstrip
C10, C14, C25	160 pF, 100 mil Chip Capacitors	Z4	0.160" x 0.080" Microstrip
C11, C22	10 μF, 50 V Electrolytic Capacitors	Z5, Z8	0.120" x 0.080" Microstrip
C12, C24	1,200 pF, 100 mil Chip Capacitors	Z6, Z7	0.120" x 0.223" Microstrip
C13, C23	0.1 μF, 100 mil Chip Capacitors	<b>Z</b> 9	1.380" x 0.080" Microstrip
C17, C18	24 pF, 100 mil Chip Capacitors	Z10	0.625" x 0.080" Microstrip
C19	160 pF, 100 mil Chip Capacitor	Board	Glass Teflon <sup>®</sup> , 31 mils
C20	8.2 pF, 100 mil Chip Capacitor		

Figure 10. 450 - 520 MHz Broadband Test Circuit

# **TYPICAL CHARACTERISTICS, 450 - 520 MHz**

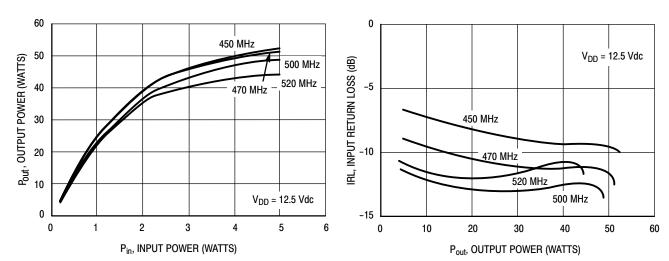


Figure 11. Output Power versus Input Power

Figure 12. Input Return Loss versus Output Power

## **TYPICAL CHARACTERISTICS, 450 - 520 MHz**



Figure 13. Gain versus Output Power

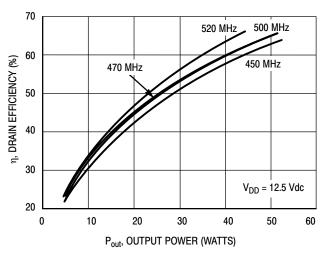


Figure 14. Drain Efficiency versus Output Power

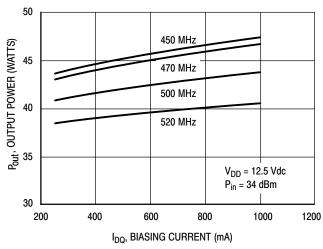


Figure 15. Output Power versus Biasing Current

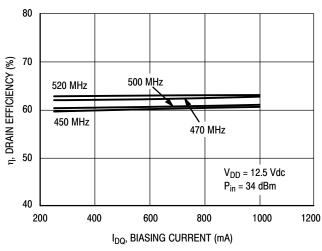


Figure 16. Drain Efficiency versus Biasing Current

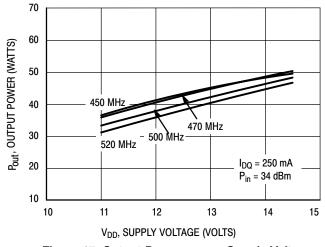


Figure 17. Output Power versus Supply Voltage

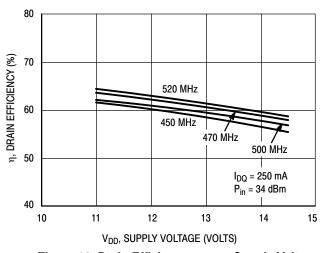
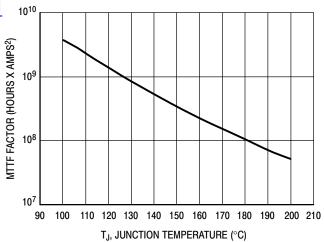


Figure 18. Drain Efficiency versus Supply Voltage

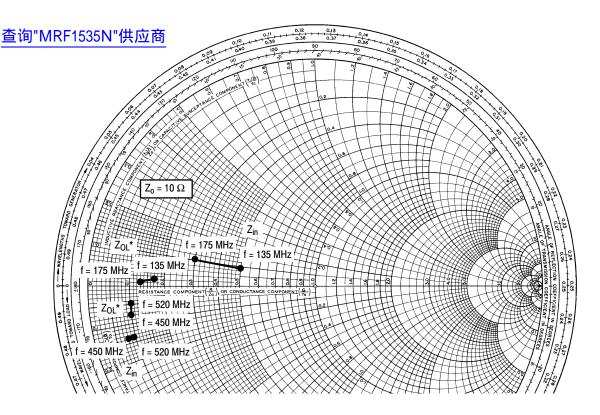
## **TYPICAL CHARACTERISTICS**

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This above graph displays calculated MTTF in hours x ampere<sup>2</sup> drain current. Life tests at elevated temperatures have correlated to better than  $\pm 10\%$  of the theoretical prediction for metal failure. Divide MTTF factor by  $I_D{}^2$  for MTTF in a particular application.

Figure 19. MTTF Factor versus Junction Temperature



 $V_{DD}$  = 12.5 V,  $I_{DQ}$  = 250 mA,  $P_{out}$  = 35 W

f MHz	<b>Z</b> <sub>in</sub> Ω	<b>Z<sub>OL</sub>*</b> Ω
135	5.0 + j0.9	1.7 + j0.2
155	5.0 + j0.9	1.7 + j0.2
175	3.0 + j1.0	1.3 + j0.1

 $V_{DD} = 12.5 \text{ V}, I_{DQ} = 500 \text{ mA}, P_{out} = 35 \text{ W}$ 

f MHz	Z <sub>in</sub>	<b>Z<sub>OL</sub>*</b> Ω
450	0.8 - j1.4	1.0 - j0.8
470	0.9 - j1.4	1.1 - j0.6
500	1.0 - j1.4	1.1 - j0.6
520	0.9 - j1.4	1.1 - j0.5

 $Z_{in}$  = Complex conjugate of source impedance.

$$\begin{split} Z_{OL}{}^{\star} &= & \text{Complex conjugate of the load} \\ & \text{impedance at given output power,} \\ & \text{voltage, frequency, and } \eta_D > 50 \ \%. \end{split}$$

Z<sub>in</sub> = Complex conjugate of source impedance.

$$\begin{split} Z_{OL}{}^{\star} &= & \text{Complex conjugate of the load} \\ &\text{impedance at given output power,} \\ &\text{voltage, frequency, and } \eta_D > 50 \ \%. \end{split}$$

Note:  $Z_{OL}^{\star}$  was chosen based on tradeoffs between gain, drain efficiency, and device stability.

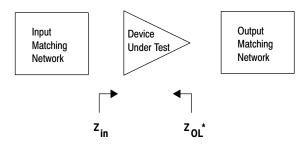


Figure 20. Series Equivalent Input and Output Impedance

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Table 5. Common Source Scattering Parameters ( $V_{DD}$  = 12.5 Vdc)

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# $I_{DQ} = 250 \text{ mA}$

f	s	11	S	21	S	12	S	22
MHz	S <sub>11</sub>	∠ ф	S <sub>21</sub>	∠ ¢	S <sub>12</sub>	∠ ф	S <sub>22</sub>	∠ ф
50	0.89	-173	8.496	83	0.014	-26	0.76	-170
100	0.90	-175	3.936	72	0.014	-14	0.79	-170
150	0.91	-175	2.429	63	0.011	-23	0.82	-170
200	0.92	-175	1.627	57	0.010	-44	0.86	-170
250	0.94	-176	1.186	53	0.007	-16	0.88	-170
300	0.95	-176	0.888	49	0.005	-44	0.91	-171
350	0.96	-176	0.686	48	0.005	36	0.92	-170
400	0.96	-176	0.568	44	0.005	-1	0.94	-171
450	0.97	-176	0.457	44	0.004	49	0.94	-172
500	0.97	-176	0.394	44	0.003	-51	0.95	-171
550	0.98	-176	0.332	42	0.001	31	0.95	-173
600	0.98	-177	0.286	41	0.013	99	0.94	-173

# $I_{DQ} = 1.0 A$

f	s	11	s	21	S	12	s	22
MHz	S <sub>11</sub>	∠ ф	S <sub>21</sub>	∠ ¢	S <sub>12</sub>	∠ ¢	S <sub>22</sub>	∠ ¢
50	0.90	-173	8.49	83	0.006	-39	0.86	-176
100	0.90	-175	3.92	72	0.009	-5	0.86	-176
150	0.91	-175	2.44	63	0.006	7	0.87	-176
200	0.92	-175	1.62	57	0.008	21	0.88	-175
250	0.94	-176	1.19	53	0.006	8	0.89	-174
300	0.95	-176	0.89	48	0.008	3	0.89	-174
350	0.96	-176	0.69	48	0.007	48	0.91	-174
400	0.96	-176	0.57	44	0.004	41	0.93	-173
450	0.97	-176	0.46	44	0.004	43	0.93	-173
500	0.97	-176	0.39	44	0.003	57	0.94	-173
550	0.98	-176	0.33	41	0.006	62	0.94	-174
600	0.98	-177	0.28	41	0.009	96	0.93	-173

# $I_{DQ} = 2.0 A$

	-DQ								
f	S	S <sub>11</sub>		21	S	12	S	22	
MHz	S <sub>11</sub>	∠ φ	S <sub>21</sub>	∠ ф	S <sub>12</sub>	∠ φ	S <sub>22</sub>	∠ ф	
50	0.94	-176	9.42	88	0.005	-72	0.89	-177	
100	0.94	-178	4.56	82	0.005	4	0.89	-177	
150	0.94	-178	2.99	78	0.003	7	0.89	-177	
200	0.94	-178	2.14	74	0.005	17	0.90	-176	
250	0.95	-178	1.67	71	0.004	40	0.90	-175	
300	0.95	-178	1.32	67	0.007	35	0.91	-175	
350	0.95	-178	1.08	67	0.005	57	0.92	-174	
400	0.96	-178	0.93	63	0.003	50	0.93	-173	
450	0.96	-178	0.78	62	0.007	68	0.93	-173	
500	0.96	-177	0.68	61	0.004	99	0.94	-173	
550	0.97	-177	0.59	58	0.008	78	0.93	-175	
600	0.97	-178	0.51	57	0.009	92	0.92	-174	

MRF1535N

#### **APPLICATIONS INFORMATION**

## DESTANICHSIDERANICHS立商

This device is a common-source, RF power, N-Channel enhancement mode, Lateral Metal-Oxide Semiconductor Field-Effect Transistor (MOSFET). Freescale Application Note AN211A, "FETs in Theory and Practice", is suggested reading for those not familiar with the construction and characteristics of FETs.

This surface mount packaged device was designed primarily for VHF and UHF mobile power amplifier applications. Manufacturability is improved by utilizing the tape and reel capability for fully automated pick and placement of parts. However, care should be taken in the design process to insure proper heat sinking of the device.

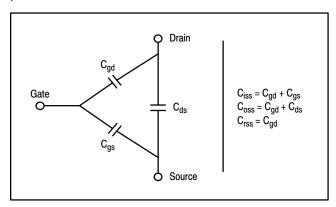
The major advantages of Lateral RF power MOSFETs include high gain, simple bias systems, relative immunity from thermal runaway, and the ability to withstand severely mismatched loads without suffering damage.

#### **MOSFET CAPACITANCES**

The physical structure of a MOSFET results in capacitors between all three terminals. The metal oxide gate structure determines the capacitors from gate-to-drain ( $C_{gd}$ ), and gate-to-source ( $C_{gs}$ ). The PN junction formed during fabrication of the RF MOSFET results in a junction capacitance from drain-to-source ( $C_{ds}$ ). These capacitances are characterized as input ( $C_{iss}$ ), output ( $C_{oss}$ ) and reverse transfer ( $C_{rss}$ ) capacitances on data sheets. The relationships between the inter-terminal capacitances and those given on data sheets are shown below. The  $C_{iss}$  can be specified in two ways:

- 1. Drain shorted to source and positive voltage at the gate.
- Positive voltage of the drain in respect to source and zero volts at the gate.

In the latter case, the numbers are lower. However, neither method represents the actual operating conditions in RF applications.



## **DRAIN CHARACTERISTICS**

One critical figure of merit for a FET is its static resistance in the full-on condition. This on-resistance,  $R_{DS(on)}$ , occurs in the linear region of the output characteristic and is specified at a specific gate-source voltage and drain current. The

drain-source voltage under these conditions is termed  $V_{DS(on)}$ . For MOSFETs,  $V_{DS(on)}$  has a positive temperature coefficient at high temperatures because it contributes to the power dissipation within the device.

BV<sub>DSS</sub> values for this device are higher than normally required for typical applications. Measurement of BV<sub>DSS</sub> is not recommended and may result in possible damage to the device.

#### **GATE CHARACTERISTICS**

The gate of the RF MOSFET is a polysilicon material, and is electrically isolated from the source by a layer of oxide. The DC input resistance is very high - on the order of  $10^9~\Omega$  — resulting in a leakage current of a few nanoamperes.

Gate control is achieved by applying a positive voltage to the gate greater than the gate-to-source threshold voltage,  $V_{\rm GS(th)}$ .

**Gate Voltage Rating** — Never exceed the gate voltage rating. Exceeding the rated  $V_{GS}$  can result in permanent damage to the oxide layer in the gate region.

**Gate Termination** — The gates of these devices are essentially capacitors. Circuits that leave the gate open-circuited or floating should be avoided. These conditions can result in turn-on of the devices due to voltage build-up on the input capacitor due to leakage currents or pickup.

Gate Protection — These devices do not have an internal monolithic zener diode from gate-to-source. If gate protection is required, an external zener diode is recommended. Using a resistor to keep the gate-to-source impedance low also helps dampen transients and serves another important function. Voltage transients on the drain can be coupled to the gate through the parasitic gate-drain capacitance. If the gate-to-source impedance and the rate of voltage change on the drain are both high, then the signal coupled to the gate may be large enough to exceed the gate-threshold voltage and turn the device on.

#### DC BIAS

Since this device is an enhancement mode FET, drain current flows only when the gate is at a higher potential than the source. RF power FETs operate optimally with a quiescent drain current ( $I_{DQ}$ ), whose value is application dependent. This device was characterized at  $I_{DQ}$  = 500 mA, which is the suggested value of bias current for typical applications. For special applications such as linear amplification,  $I_{DQ}$  may have to be selected to optimize the critical parameters.

The gate is a dc open circuit and draws no current. Therefore, the gate bias circuit may generally be just a simple resistive divider network. Some special applications may require a more elaborate bias system.

#### **GAIN CONTROL**

Power output of this device may be controlled to some degree with a low power dc control signal applied to the gate, thus facilitating applications such as manual gain control, ALC/AGC and modulation systems. This characteristic is very dependent on frequency and load line.



#### **AMPLIFIER DESIGN**

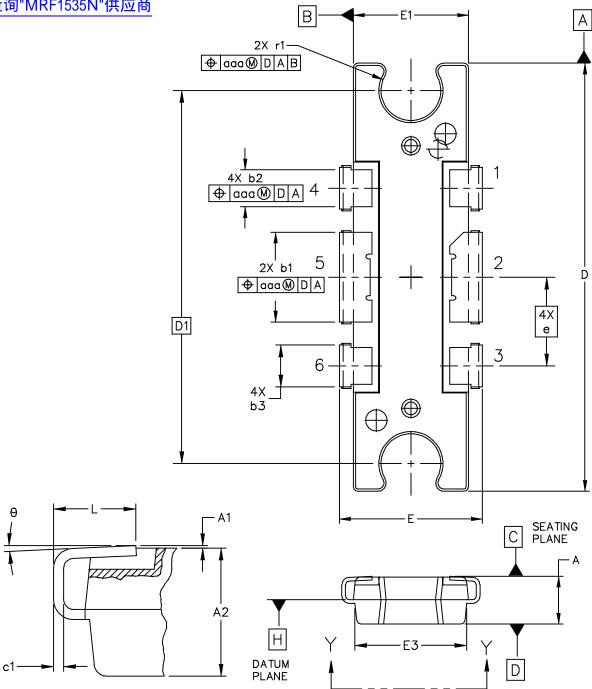
Impedance matching networks similar to those used with the polar translators are suitable for this device. For examples see Freescale Application Note AN721, "Impedance Matching Networks Applied to RF Power Transistors." Large-signal impedances are provided, and will yield a good first pass approximation.

Since RF power MOSFETs are triode devices, they are not unilateral. This coupled with the very high gain of this device yields a device capable of self oscillation. Stability may be achieved by techniques such as drain loading, input shunt resistive loading, or output to input feedback. The RF test fixture implements a parallel resistor and capacitor in series with the gate, and has a load line selected for a higher efficiency, lower gain, and more stable operating region.

Two-port stability analysis with this device's S-parameters provides a useful tool for selection of loading or feedback circuitry to assure stable operation. See Freescale Application Note AN215A, "RF Small-Signal Design Using Two-Port Parameters" for a discussion of two port network theory and stability.

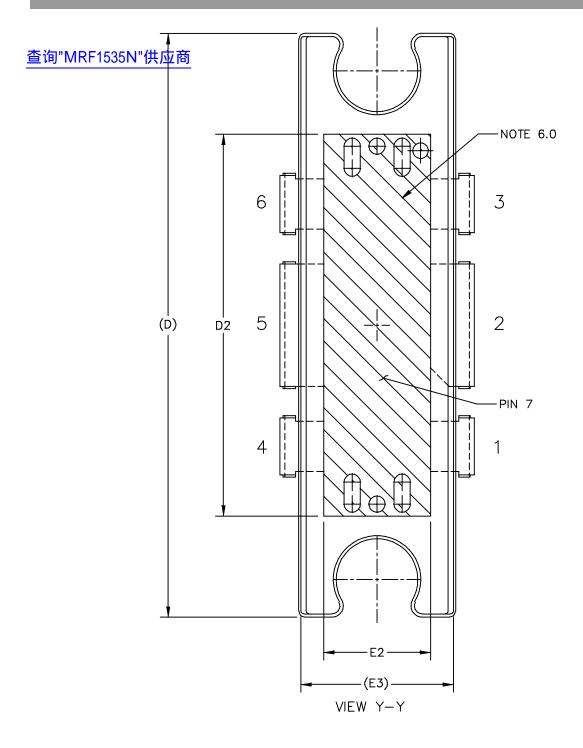
## **PACKAGE DIMENSIONS**





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TITLE:	DOCUMENT NO	): 98ASH98116A	REV: L
TO-272 SCRFW DOWN MOU	CASE NUMBER	R: 1264−10	03 AUG 2007
SCINEW DOWN WOO	STANDARD: JE	DEC TO-272 AA	





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TO-272 SCRFW DOWN MOU	INIT C	CASE NUMBER	: 1264–10	03 AUG 2007
SCINEW BOWN WOO		STANDARD: JEI	DEC TO-272 AA	

#### NOTES:

- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
- 4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS . 006 PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
- 5. DIMENSIONS "61" AND "63" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "61" AND "62" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
- 6. CROSSHATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.

#### STYLE 1:

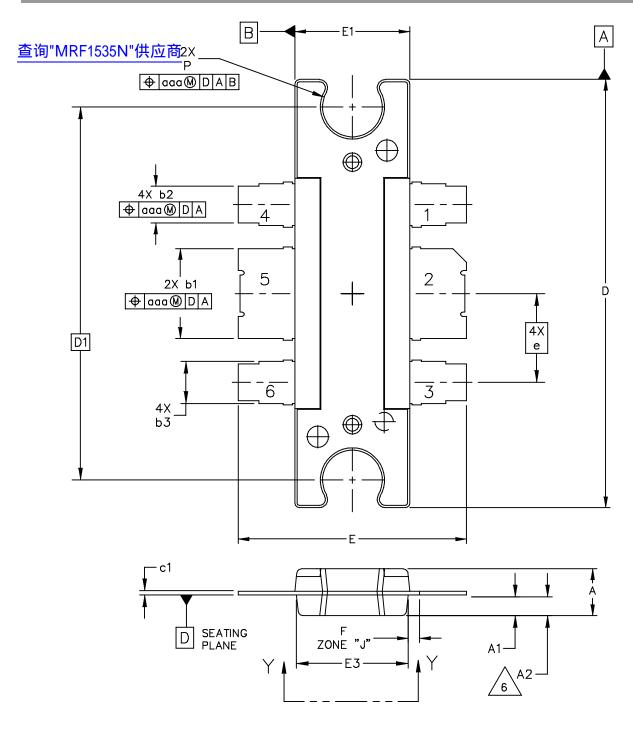
PIN 1 - SOURCE (COMMON) PIN 4 - SOURCE (COMMON) PIN 2 - DRAIN PIN 5 - GATE PIN 3 - SOURCE (COMMON) PIN 6 - SOURCE (COMMON) PIN 7 - SOURCE (COMMON)

	INCH		MILLIMETER			INCH		MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
Α	.098	.108	2.49	2.74	b1	.193	.199	4.90	5.05
A1	.000	.004	0.00	0.10	b2	.078	.084	1.98	2.13
A2	.100	.104	2.54	2.64	b3	.088	.094	2.24	2.39
D	.928	.932	23.57	23.67	c1	.007	.011	0.18	0.28
D1	.806	.814	20.47	20.68	e	.193 BSC		4.90 BSC	
D2	.604		15.34		r1	.063	.068	1.60	1.73
E	.296	.304	7.52	7.72	9	0.	6.	0.	6.
E1	.248	.252	6.30	6.40	aaa	.004		c	).1
E2	.162		4.11						
E3	.241	.245	6.12	6.22					
L	.060	.070	1.52	1.78					
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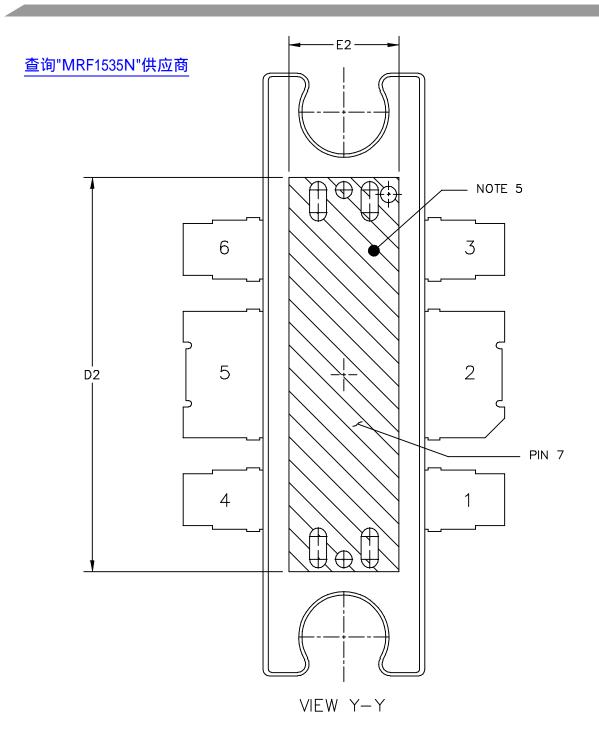
TITLE:

TO - 272SCREW DOWN MOUNT DOCUMENT NO: 98ASH98116A REV: L CASE NUMBER: 1264-10 03 AUG 2007

STANDARD: JEDEC TO-272 AA



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TITLE:	\	DOCUMENT NO: 98ASA10536D		REV: D
TO-272, 6 LEAD PLASTIC	•	CASE NUMBER: 1264A-03		03 AUG 2007
T EASTIC		STANDARD: JE	DEC TO-272 BA	



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TITLE:		DOCUMENT NO	): 98ASA10536D	REV: D	
TO-272, 6 LEAD		CASE NUMBER: 1264A-03		03 AUG 2007	
PLASTIC		STANDARD: JE	DEC TO-272 BA		



#### NOTES:

## 查询"MONTENSION: INCH

- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE —H—.
- 4. DIMENSIONS "b1" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" AND "b2" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
- 5. CROSSHATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.
- 6. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.

### STYLE 1:

PIN 1 - SOURCE (COMMON) PIN 4 - SOURCE (COMMON)

PIN 2 - DRAIN PIN 5 - GATE

PIN 3 - SOURCE (COMMON) PIN 6 - SOURCE (COMMON) PIN 7 - SOURCE (COMMON)

INCH MILLIMETER INCH MILLIMETER DIM MIN MAXMIN MAXDIM MIN  $\mathsf{MAX}$ MIN MAXΑ .098 .106 2.49 2.69 .193 .199 4.90 5.05 b1 .044 Α1 .038 0.96 1.12 b2 .078 .084 1.98 2.13 .040 .094 2.24 2.39 A2 .0421.02 1.07 b3 .088 .926 .934 23.52 23.72 .007 .279 D c1 .011 .178 D1 .810 BSC 20.57 BSC е .193 BSC 4.90 BSC D<sub>2</sub> .604 15.34 Ε 12.50 .492 .500 12.70 aaa .004 0.1 E1 .246 .254 6.25 6.45 E2 .162 \_\_\_\_ 4.11 \_\_\_\_ .245 E3 .241 6.12 6.22 F .025 BSC 0.64 BSC Р .126 3.20 .134 3.40

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MECHANICAL OUTLINE PRINT VERSION NOT TO SCALE

DOCUMENT NO: 98ASA10536D REV: D

CASE NUMBER: 1264A-03 03 AUG 2007

STANDARD: JEDEC TO-272 BA

## PRODUCT DOCUMENTATION, TOOLS AND SOFTWARE

Real MRE 1535N"供应商s to aid your design process.

## **Application Notes**

- AN211A: Field Effect Transistors in Theory and Practice
- AN215A: RF Small-Signal Design Using Two-Port Parameters
- AN721: Impedance Matching Networks Applied to RF Power Transistors
- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN3263: Bolt Down Mounting Method for High Power RF Transistors and RFICs in Over-Molded Plastic Packages
- AN3789: Clamping of High Power RF Transistors and RFICs in Over-Molded Plastic Packages

## **Engineering Bulletins**

• EB212: Using Data Sheet Impedances for RF LDMOS Devices

#### Software

• Electromigration MTTF Calculator

For Software and Tools, do a Part Number search at http://www.freescale.com, and select the "Part Number" link. Go to the Software & Tools tab on the part's Product Summary page to download the respective tool.

#### **REVISION HISTORY**

The following table summarizes revisions to this document.

Revision	Date	Description
11	Feb. 2008	<ul> <li>Changed DC Bias I<sub>DQ</sub> value from 150 to 500 to match Functional Test I<sub>DQ</sub> specification, p. 10</li> <li>Replaced Case Outline 1264-09 with 1264-10, Issue L, p. 1, 12-14. Removed Drain-ID label from top view and View Y-Y. Corrected cross hatch pattern and its dimensions (D2 and E2) on source contact. Renamed E2 with E3. Added Pin 7 designation. Corrected positional tolerance for bolt hole radius. Added JEDEC Standard Package Number.</li> </ul>
		<ul> <li>Replaced Case Outline 1264A-02 with 1264A-03, Issue D, p. 1, 15-17. Removed Drain-ID label from View Y-Y. Corrected cross hatch pattern and its dimensions (D2 and E2) on source contact (Changed D2 and E2 dimensions from basic to .604 Min and .162 Min, respectively). Added dimension E3. Added Pin 7 designation. Corrected positional tolerance for bolt hole radius. Added JEDEC Standard Package Number.</li> <li>Added Product Documentation and Revision History, p. 18</li> </ul>
12	June 2008	Corrected specified performance values for power gain and efficiency on p. 1 to match typical performance values in the functional test table on p. 2
13	June 2009	<ul> <li>Modified data sheet to reflect MSL rating change from 1 to 3 as a result of the standardization of packing process as described in Product and Process Change Notification number, PCN13516, p. 1</li> <li>Added AN1907, Solder Reflow Attach Method for High Power RF Devices in Plastic Packages and AN3789, Clamping of High Power RF Transistors and RFICs in Over-Molded Plastic Packages to Product Documentation, Application Notes, p. 18</li> <li>Added Electromigration MTTF Calculator availability to Product Software, p. 18</li> </ul>



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Rev. 13, 6/2009

